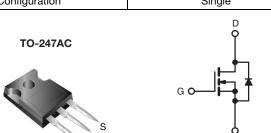


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	50	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.28				
Q _g (Max.) (nC)	13	130				
Q _{gs} (nC)	33	33				
Q _{gd} (nC)	59	59				
Configuration	Sing	Single				



N-Channel MOSFET

FEATURES

• SuperFast Body Diode Eliminates the Need For External Diodes in ZVS Applications



- Low Gate Charge Results in Simple Drive Requirement
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise **Immunity**
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supply
- Motor Control applications

ORDERING INFORMATION				
Package	TO-247AC			
Lead (Pb)-free	IRFP17N50LPbF			
	SiHFP17N50L-E3			
SnPb	IRFP17N50L			
Oili D	SiHFP17N50L			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	- V	
Gate-Source Voltage			V_{GS}	± 30		
Continuous Drain Current	V at 10 V	T _C = 25 °C		16		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	ID	11	А	
Pulsed Drain Current ^a	I _{DM}	64				
Linear Derating Factor				1.8	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	390	mJ	
Repetitive Avalanche Currenta			I _{AR}	16	А	
Repetitive Avalanche Energy ^a			E _{AR}	22	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	220	W	
Peak Diode Recovery dV/dt ^c			dV/dt	13	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150		
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	°C	
Maratha Tana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque			Ī	1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 3.0 mH, R_g = 25 Ω , I_{AS} = 16 A (see fig. 12).
- c. $I_{SD} \le 16$ Å, $dI/dt \le 347$ Å/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP17N50L, SiHFP17N50L



THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.56			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							,
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA ^d	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zona Cata Valtaga Duain Comunit	1	V _{DS} =	= 500 V, V _{GS} = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	V, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 9.9 A^b$	-	0.28	0.32	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 9.9 A ^b	11	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	2760	-	
Output Capacitance	Coss		$V_{DS} = 25 \text{ V},$	-	325	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	37	-	1
Output Canaditanas		V _{DS} = 1.0 V , f = 1.0 MHz V _{DS} = 400 V , f = 1.0 MHz		-	3690	-	pF
Output Capacitance	C_{oss}			-	84	-	
Effective Output Capacitance	C _{oss} eff.	$V_{GS} = 0 V$	V _{DS} = 0 V to 400 V	-	159	-	
Effective Output Capacitance (Energy Related)	C _{oss} eff. (ER)			-	120	-	
Internal Gate Resistance	R _g	f = 1	MHz, open drain	-	1.4	-	Ω
Total Gate Charge	Qg	V _{GS} = 10 V		_	-	130	nC
Gate-Source Charge	Q_{gs}			-	-	33	
Gate-Drain Charge	Q _{gd}			-	-	59	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 250 V, I _D = 16 A R _G = 7.5 Ω, V _{GS} = 10 V see fig. 14a and 14b ^b		-	21	=.	ns
Rise Time	t _r			-	51	-	
Turn-Off Delay Time	t _{d(off)}			-	50	-	
Fall Time	t _f			-	28	-	
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	16	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	64	A
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 16 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C		-	170	250	
		T _J = 125 °C	I _F = 16 A,	-	220	330	ns
Dat Dist Danie Barrer Ci	Q _{rr}	T _J = 25 °C	$dI/dt = 100 \text{ A/}\mu\text{s}^b$	-	470	710	
Body Diode Reverse Recovery Charge		T _J = 125 °C		-	810	1210	μC
Reverse Recovery Current	I _{RRM}		T _J = 25 °C	-	7.3	11	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn-	on is dor	ninated b	v Le and	Γ <i>ν</i>)

<sup>a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. C_{OSS} eff. is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising fom 0 % to 80 % V_{DS}. C_{OSS} eff. (ER) is a fixed capacitance that stores the same energy as C_{OSS} while V_{DS} is rising fom 0 % to 80 % V_{DS}.</sup>



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

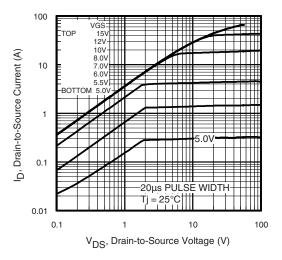


Fig. 1 - Typical Output Characteristics

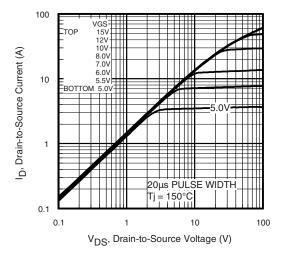


Fig. 2 - Typical Output Characteristics

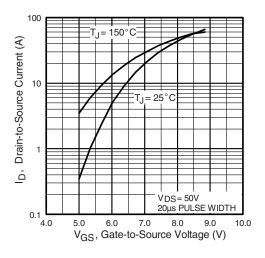


Fig. 3 - Typical Transfer Characteristics

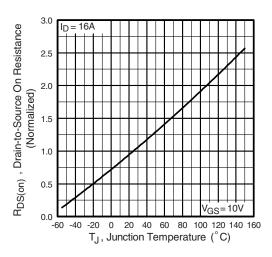


Fig. 4 - Normalized On-Resistance vs. Temperature



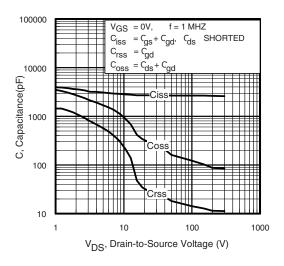


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

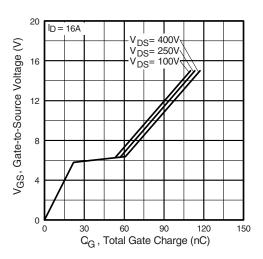


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

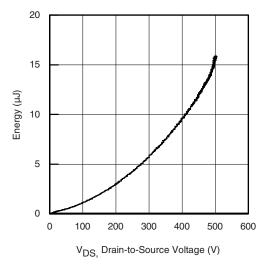


Fig. 6 - Typ. Output Capacitance Stored Energy vs. \mathbf{V}_{DS}

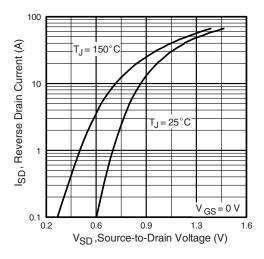


Fig. 8 - Typical Source-Drain Diode Forward Voltage



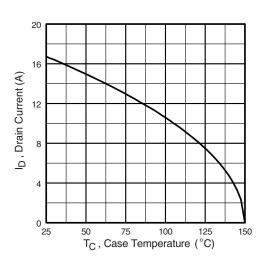


Fig. 9 - Maximum Drain Current vs. Case Temperature

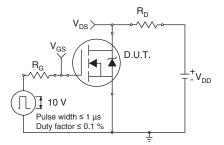


Fig. 10a - Switching Time Test Circuit

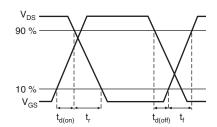


Fig. 10b - Switching Time Waveforms

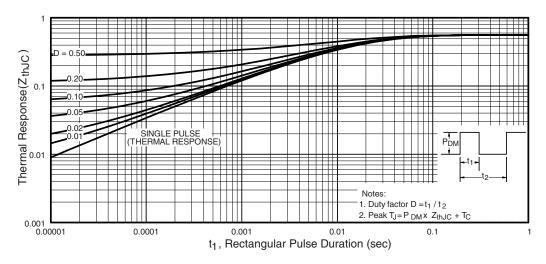


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



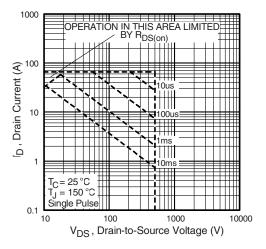


Fig. 12 - Maximum Safe Operating Area

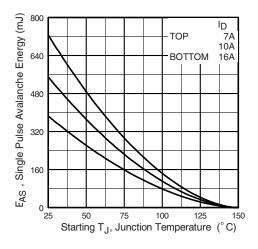


Fig. 13 - Maximum Avalanche Energy vs. Drain Current

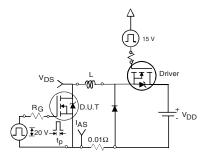


Fig. 14a - Unclamped Inductive Test Circuit

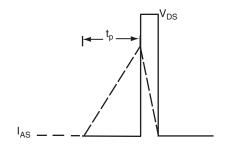


Fig. 14b - Unclamped Inductive Waveforms

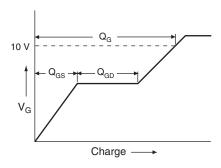


Fig. 15a - Basic Gate Charge Waveform

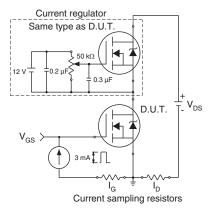
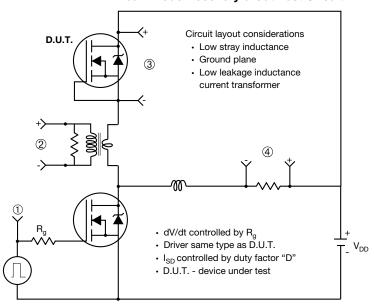


Fig. 15b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



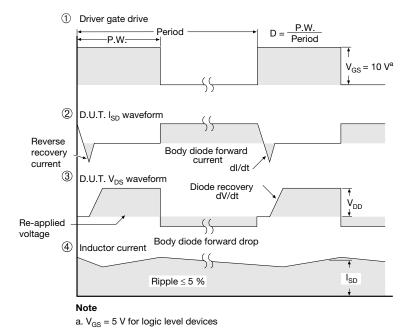
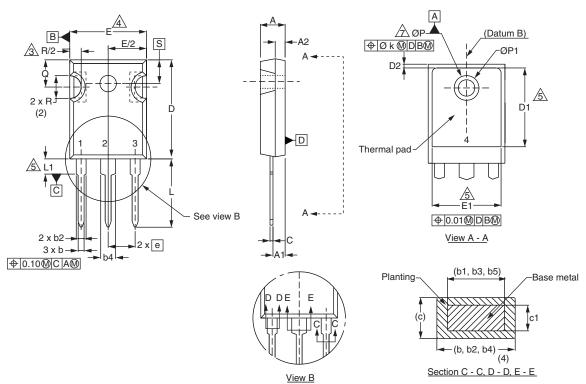


Fig. 16. For N-Channel

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TO-247AC (High Voltage)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	-	0.540	=	
е	5.46	BSC	0.215 BSC		
Øk	0.2	0.254		0.010	
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62 BSC		0.300 BSC		
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217 BSC		

ECN: X13-0045-Rev. C, 18-Mar-13

DWG: 5971

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1. 5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 18-Mar-13 Document Number: 91360



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Revision: 02-Oct-12 Document Number: 91000